

April 1988 Revised September 2000

74F193

Up/Down Binary Counter with Separate Up/Down Clocks

General Description

The 74F193 is an up/down modulo-16 binary counter. Separate Count Up and Count Down Clocks are used, and in either counting mode the circuits operate synchronously. The outputs change state synchronously with the LOW-to-HIGH transitions on the clock inputs. Separate Terminal Count Up and Terminal Count Down outputs are provided

that are used as the clocks for subsequent stages without extra logic, thus simplifying multi-stage counter designs. Individual preset inputs allow the circuit to be used as a programmable counter. Both the Parallel Load (\overline{PL}) and the Master Reset (MR) inputs asynchronously override the clocke

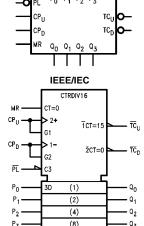
Ordering Code:

Order Number	Package Number	Package Description
74F193SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F193SJ (Note 1)	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F193PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

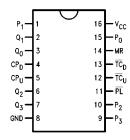
Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Note 1: Device not available in Tape and Reel.

Logic Symbols



Connection Diagram



© 2000 Fairchild Semiconductor Corporation

DS009497

www.fairchildsemi.com

Unit Loading/Fan Out

Pin Names	D	U.L.	Input I _{IH} /I _{IL}	
	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
CPU	Count Up Clock Input (Active Rising Edge)	1.0/3.0	20 μA/–1.8 mA	
CP _D	Count Down Clock Input (Active Rising Edge)	1.0/3.0	20 μA/–1.8 mA	
MR	Asynchronous Master Reset Input (Active HIGH)	1.0/1.0	20 μA/-0.6 mA	
PL	Asynchronous Parallel Load Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
P ₀ -P ₃	Parallel Data Inputs	1.0/1.0	20 μA/-0.6 mA	
Q ₀ –Q ₃	Flip-Flop Outputs	50/33.3	−1 mA/20 mA	
TC _D	Terminal Count Down (Borrow) Output (Active LOW)	50/33.3	−1 mA/20 mA	
TC _U	Terminal Count Up (Carry) Output (Active LOW)	50/33.3	−1 mA/20 mA	

Functional Description

The 74F193 is a 4-bit binary synchronous up/down (reversible) counter. It contains four edge-triggered flip-flops, with internal gating and steering logic to provide master reset, individual preset, count up and count down operations.

A LOW-to-HIGH transition on the CP input to each flip-flop causes the output to change state. Synchronous switching, as opposed to ripple counting, is achieved by driving the steering gates of all stages from a common Count Up line and a common Count Down line, thereby causing all state changes to be initiated simultaneously. A LOW-to-HIGH transition on the Count Up input will advance the count by one; a similar transition on the Count Down input will decrease the count by one. While counting with one clock input, the other should be held HIGH, as indicated in the Function Table.

The Terminal Count Up (\overline{TC}_U) and Terminal Count Down (\overline{TC}_D) outputs are normally HIGH. When the circuit has reached the maximum count state 15, the next HIGH-to-LOW transition of the Count Up Clock will cause \overline{TC}_U to go LOW. \overline{TC}_U will stay LOW until CP $_U$ goes HIGH again, thus effectively repeating the Count Up Clock, but delayed by two gate delays. Similarly, the \overline{TC}_D output will go LOW when the circuit is in the zero state and the Count Down Clock goes LOW. Since the \overline{TC} outputs repeat the clock waveforms, they can be used as the clock input signals to the next higher order circuit in a multistage counter.

$$\begin{aligned} \overline{TC}_U &= Q_0 \bullet Q_1 \bullet Q_2 \bullet Q_3 \bullet \overline{CP}_U \\ \overline{TC}_D &= \overline{Q}_0 \bullet \overline{Q}_1 \bullet \overline{Q}_2 \bullet \overline{Q}_3 \bullet \overline{CP}_D \end{aligned}$$

The 74F193 has an asynchronous parallel load capability permitting the counter to be preset. When the Parallel Load (\overline{PL}) and the Master Reset (MR) inputs are LOW, information present on the Parallel Data input (P_0-P_3) is loaded into the counter and appears on the outputs regardless of the conditions of the clock inputs. A HIGH signal on the Master Reset input will disable the preset gates, override both clock inputs, and latch each Q output in the LOW state. If one of the clock inputs is LOW during and after a reset or load operation, the next LOW-to-HIGH transition of that clock will be interpreted as a legitimate signal and will be counted.

Function Table

MR	PL	CPU	CPD	Mode
Н	Х	Х	Х	Reset (Asyn.)
L	L	Х	Х	Preset (Asyn.)
L	Н	Н	Н	No Change
L	Н	~	Н	Count Up
L	Н	Н	~	Count Down

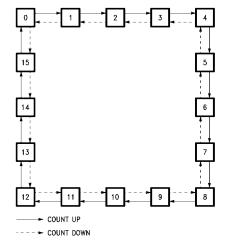
H = HIGH Voltage Level

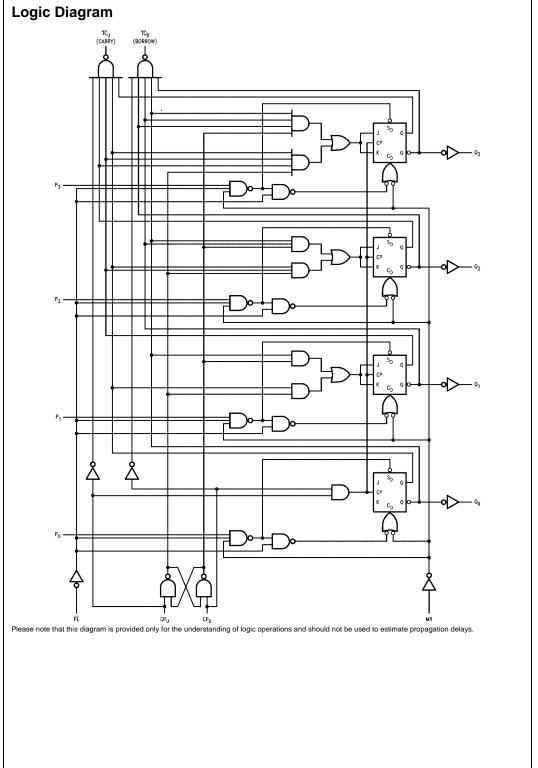
L = LOW Voltage Level

< = Immaterial</p>

∠ = LOW-to-HIGH Clock Transition

State Diagram





Absolute Maximum Ratings(Note 2)

Recommended Operating Conditions

Storage Temperature -65°C to $+150^{\circ}\text{C}$ Ambient Temperature under Bias -55°C to $+125^{\circ}\text{C}$

Input Current (Note 3) $\label{eq:Voltage Applied to Output}$ in HIGH State (with V $_{CC} = 0V$)

 $\begin{array}{ll} \mbox{Standard Output} & -0.5\mbox{V to V}_{\mbox{CC}} \\ \mbox{3-STATE Output} & -0.5\mbox{V to +5.5}\mbox{V} \end{array}$

Current Applied to Output

in LOW State (Max) $\qquad \qquad \text{twice the rated I}_{\text{OL}} \, (\text{mA})$

Free Air Ambient Temperature 0°C to $+70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 2: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 3: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		Min	Тур	Max	Units	v _{cc}	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				8.0	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	10% V _{CC}	2.5			V	Min	I _{OH} = -1 mA	
	Voltage	5% V _{CC}	2.7			•	I IVIIII	$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW Voltage	10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA	
I _{IH}	Input HIGH				5.0		Max	V _{IN} = 2.7V	
	Current				3.0		IVIGA	V _{IN} = 2.7 V	
I _{BVI}	Input HIGH Current				100	μА	Max	V _{IN} = 7.0V	
	Breakdown Test				7.0	μА	IVIAX	$v_{IN} = 7.0 v$	
I _{CEX}	Output HIGH				50	μА	Max	V - V	
	Leakage Current				30	μΛ	IVIAA	$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu A$	
	Test		4.73			v	0.0	All Other Pins Grounded	
I _{OD}	Output Leakage				3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current				3.73	μА	0.0	All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6			$V_{IN} = 0.5V (MR, \overline{PL}, P_n)$	
					-1.8	mA	Max	$V_{IN} = 0.5V (CP_u, CP_D)$	
Ios	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V	
I _{CC}	Power Supply Current			38	55	mA	Max		

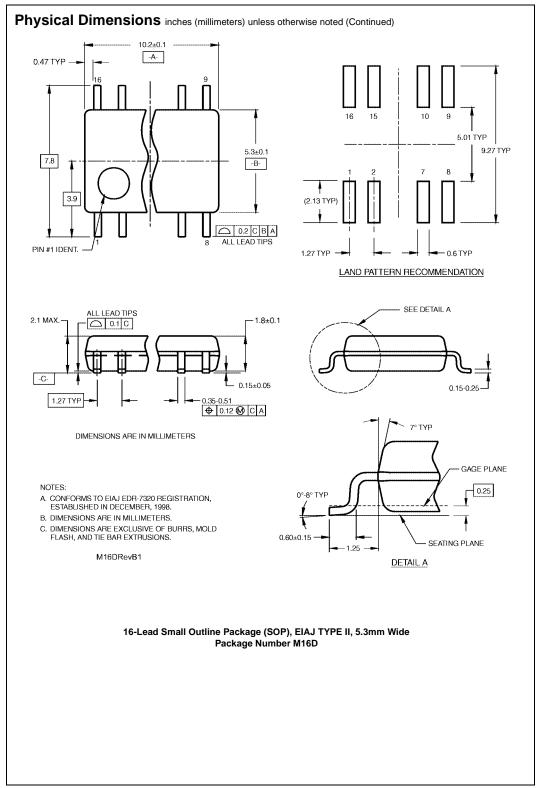
AC Electrical Characteristics

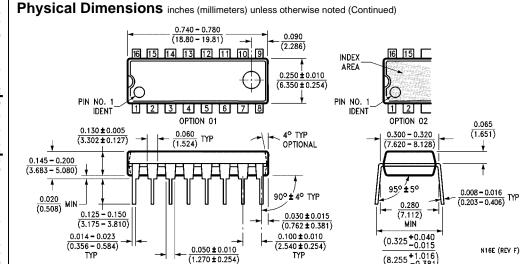
Symbol	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to $+70$ °C $V_{CC} = +5.0$ V $C_L = 50$ pF		
		Min	Тур	Max	Min	Max		
f _{MAX}	Maximum Count Frequency	100	125		90		MHz	
t _{PLH}	Propagation Delay	4.0	7.0	9.0	4.0	10.0		
t _{PHL}	CP _U or CP _D to	3.5	6.0	8.0	3.5	9.0	ns	
	TC _U or TC _D							
t _{PLH}	Propagation Delay	4.0	6.5	8.5	4.0	9.5	ns	
t _{PHL}	CP _U or CP _D to Q _n	5.5	9.5	12.5	5.5	13.5	115	
t _{PLH}	Propagation Delay	3.0	4.5	7.0	3.0	8.0	20	
t _{PHL}	P _n to Q _n	6.0	11.0	14.5	6.0	15.5	ns	
t _{PLH}	Propagation Delay	5.0	8.5	11.0	5.0	12.0	20	
t _{PHL}	PL to Q _n	5.5	10.0	13.0	5.5	14.0	ns	
t _{PHL}	Propagation Delay	5.5	11.0	14.5	5.5	15.5		
	MR to Q _n	5.5	11.0	14.5	5.5	15.5		
t _{PLH}	Propagation Delay	6.0	10.5	13.5	6.0	14.5	ns	
	MR to TC _U	0.0	10.5	13.3	0.0	14.5	115	
t _{PHL}	Propagation Delay	6.0	11.5	14.5	6.0	15.5		
	MR to TC _D	0.0	11.5	14.5	0.0	13.3		
t _{PLH}	Propagation Delay	7.0	12.0	15.5	7.0	16.5	no	
t _{PHL}	PL to TC _U or TC _D	7.0	11.5	14.5	7.0	15.5	ns	
t _{PLH}	Propagation Delay	7.0	11.5	14.5	7.0	15.5	ne	
t _{PHL}	P_n to \overline{TC}_U or \overline{TC}_D	6.5	11.0	14.0	6.5	15.0	ns	

AC Operating Requirements

		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$		Units
Symbol	Parameter					
		Min	Max	Min	Max	
t _S (H)	Setup Time, HIGH or LOW	4.5		5.0		
t _S (L)	P _n to PL	4.5		5.0		ns
t _H (H)	Hold Time, HIGH or LOW	2.0		2.0		113
t _H (L)	P_n to \overline{PL}	2.0		2.0		
t _W (L)	PL Pulse Width, LOW	6.0		6.0		ns
t _W (L)	CP _U or CP _D	5.0		5.0		ns
	Pulse Width, LOW	5.0		5.0		113
t _W (L)	CP _U or CP _D					
	Pulse Width, LOW	10.0		10.0		ns
	(Change of Direction)					
t _W (H)	MR Pulse Width, HIGH	6.0		6.0		ns
t _{REC}	Recovery Time	6.0		6.0		ns
	PL to CP _U or CP _D	0.0		0.0		115
t _{REC}	Recovery Time	4.0		4.0		ns
	MR to CP _U or CP _D			4.0		113

Physical Dimensions inches (millimeters) unless otherwise noted $\frac{0.386 - 0.394}{(9.804 - 10.00)}$ 13 Ĥ 0.228 - 0.244 (5.791 - 6.198) LEAD NO.1 0.010 (0.254) MAX $\frac{0.150 - 0.157}{(3.810 - 3.988)}$ $\frac{0.053 - 0.069}{(1.346 - 1.753)}$ $\frac{0.010 - 0.020}{(0.254 - 0.508)}$ 0.004 - 0.010 (0.102 - 0.254) 8° MAX TYP ALL LEADS SEATING PLANE 0.008 - 0.010 (0.203 - 0.254) TYP ALL LEADS 0.014 0.050 (1.270) TYP 0.014 - 0.020 TYP 0.016 - 0.050 (0.406 - 1.270) TYP ALL LEADS 0.004 (0.102) All Lead TIPS 0.008 (0.203) TYP M16A (REV H) 16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A





16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

www.fairchildsemi.com